

SEMI F47 Voltage Sag Immunity Test Report for Power Supply CP10.241



Other devices covered by this report:

CP10.24x-ww	Standard ur	nits
CP10.24x-Sz-ww	Standard units with different terminal options	
CP10.24x-Ry-ww	Units with built-in redundancy	
х:	1	Input voltage: AC 100-240V, DC 110-150V
	2	Input voltage: AC 100-240V, DC 110-300V
y:	1	Spring-clamp terminals (tool free)
	3	Screw terminals
z:	1	Spring-clamp terminals (tool free)
	2	Spring-clamp terminals (push-in type)
ww:	C1	Version with conformal coated pc-boards
R	constant character - indicates units with built-in redundancy	
S	constant character - indicates terminal options	

Document revision: 1

SEMI F47 Test Report



Document number	CP10.241 Semi F47 Rev1	TR1
Approval order number	LAB 20-800	
Standards	Sag Immunity Compliance IEC 61000-4-11 2004 +A2 Electromagnetic compat techniques - Voltage dip	ICONDUCTOR PROCESSING EQUIPMENT - Voltage re Tests
Applicant	PULS GmbH Elektrastraße 6 81925 Munich, Germany	,
Test Laboratory	PULS Vario GmbH Kranichberggasse 6 1120 Vienna, Austria	
Test Engineer	Thomas Ramel	
Test Date	15.06.2020 - 16.06.2020	
Description of Test Device:	Built-in power supplies f	or DIN-Rail mounting
Devices under Evaluation:	CP10.241 Input: AC 100-240V, Output: DC 24-28V, 10A	
S/N of Devices:	CP10.241: S/N: 2020516	6 F
Application Details:	Input voltage: Input frequency: Output load:	1-Phase AC 208V 50 or 60Hz 240W



PASS/FAIL Criterions:

Test Result:

PASS

value

The test device passed all essential SEMI F47-0706 tests according to the defined application details without any limitations and is qualified to bear the following approval mark:

The output voltage is not allowed to deviated more than 5% of the initial

DC OK contact is not allowed to trigger during and after the test

In accordance with paragraph 7.8.2 a) of SEMI F47-0706



Since DC power supplies, as covered in this test report, are only components of a semiconductor processing equipment, the tests of the SEMI F47 standard were conducted with selected rated characteristics of the DC power supply.

The system integrator of the final semiconductor processing equipment needs to judge if the results of this test report are compatible with the SEMI F47 requirements of his system or if test data under other operating conditions are additionally required.

The system integrator also needs to judge if the results of the inrush current peaks are compatible with the selected external fuses for input protection.

The system integrator also needs to be aware about aging effects. It is expected that the ride through time can be reduced by 15% at end of the specified lifetime expectancy.

A SEMI F47 certificate is not intended for this type of component, however the product fulfils the general requirements and can be marked with the following symbol.

Approved

Harald Etlinger Sr. Qualification Eng. PULS Vario GmbH, Vienna

Date of Approval

26.06.2020



Copy of marking plate:



List of Test Equipment

Туре	Model	Inventory number
Test generator:	Kikusui PCR3000WE2	10381
Load:	el. Load Chroma 63201	10046
Oscilloscope:	LeCroy WS454	10130
Oscilloscope:	LeCroy WS424	10127
Diffential probe.	Lecroy	10246
Current Probe:	LeCroy CP30	10378

The test equipment complies with the requirements of IEC 61000-4-11.

The peak current capability of the test generator was evaluated according Annex A of IEC 61000-4-11 and is able to deliver minimum 32.7A.

Test Specification for SEMI F47 compliance

Voltage Sag Immunity according to the following table:

Sag depth#1	Duration	Duration at 50 Hz	Duration at 60 Hz
50%	200ms	10 cycles	12 cycles
70%	500ms	25 cycles	30 cycles
80%	1000ms	50 cycles	60 cycles

#1 Sag depth is expressed in percent of remaining nominal voltage. For example, during a 70% voltage sag on a 200 volt nominal system, the voltage is reduced during the sag to 140 volts and not 60 volts.

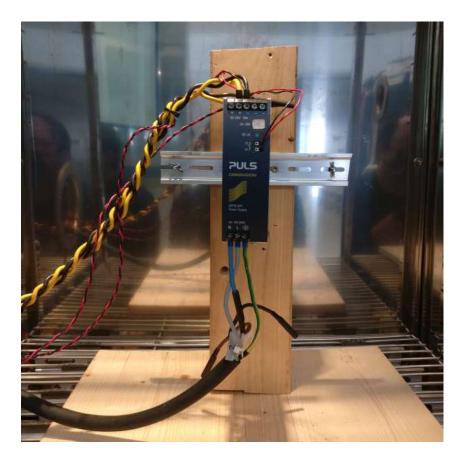


Test Setup

The unit under test in normal operating condition mounted in climate chamber. The input is connected to an AC Source. The input voltage is measured with a 100:1 differential probe and the input current is measured with current probes. These probes are connected to oscilloscopes.

The output is connected to an active load. The output voltage is connected directly to the oscilloscope. "DC-OK" signal is also measured with an oscilloscope.

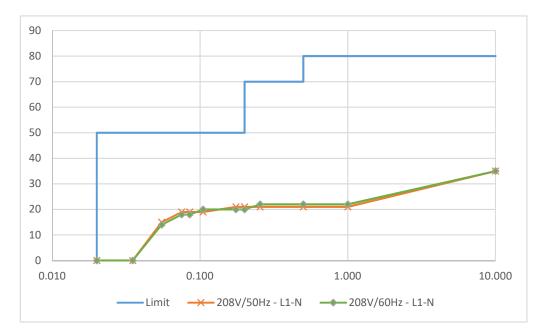
Input and output voltages are measured with oscilloscope #1 and input currents with oscilloscope #2.

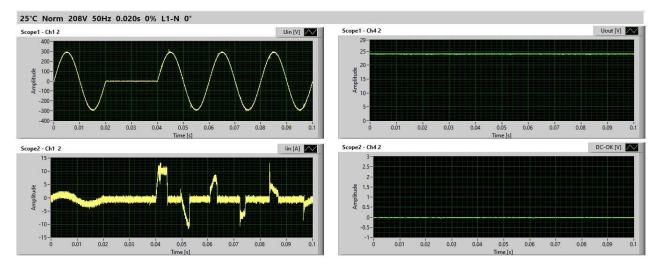


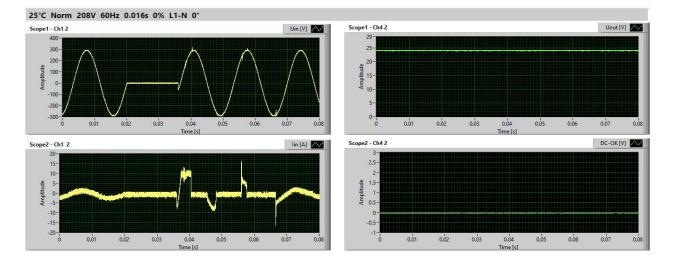




Voltage Sag Results







Date: 26.06.2020



Conducted Tests at 208V 50Hz

Input voltage	208Vac
Input Frequency	50Hz
Output voltage	24V
Output current	10A
Ambient temperature	25°C

Sag duration [s]	Voltage remaining [%]	Pos. peak current [A]	Neg. peak current [A]
0.020	0	13.1	-11.7
0.200	50	5.6	-8
0.500	70	4.2	-4.7
1	80	3.3	-4.7
10	80	3.3	-4.2

Informational measurements

Sag duration [s]	Voltage remaining [%]	Sag duration [s]	Voltage remaining [%]
0.020	0	0.175	21
0.035	0	0.200	21
0.055	15	0.255	21
0.075	19	0.500	21
0.085	19	1	21
0.105	19	10	35

Conducted Tests at 208V 60Hz

Input voltage	208Vac
Input Frequency	60Hz
Output voltage	24V
Output current	10A
Ambient temperature	25°C

Sag duration [s]	Voltage remaining [%]	Pos. peak current [A]	Neg. peak current [A]
0.016	0	16.4	-16.4
0.200	50	5.6	-6.6
0.500	70	4.2	-4.7
1	80	3.3	-4.2
10	80	3.3	-4.7

Informational measurements

Sag duration [s]	Voltage remaining [%]	Sag duration [s]	Voltage remaining [%]
0.016	0	0.175	20
0.035	0	0.200	20
0.055	14	0.255	22
0.075	18	0.500	22
0.085	18	1	22
0.105	20	10	35



Inrush current measurements according 61000-4-11 at 208V 50Hz

Input voltage	208Vac
Input Frequency	50Hz
Output voltage	24V
Output current	10A
Ambient temperature	25°C

Peak input current measurements on unit under test:

First two measurements turn off input power for EUT for 5 minutes and then

s and
5

Inrush current measurements according 61000-4-11 at 208V 60Hz

Input voltage	208Vac
Input Frequency	60Hz
Output voltage	24V
Output current	10A
Ambient temperature	25°C

Peak input current measurements on unit under test:

First two measurements turn off input power for EUT for 5 minutes and thenMeasure peak input current when AC turned on at 90°:6.1AMeasure peak input current when AC turned on at 270°:7Aon again.6.1A

Measure peak input current when AC turned on at 90°:4.7AMeasure peak input current when AC turned on at 270°:6.6A



Operating conditions and their influence in test results:

a) Ambient temperature:

Control measurements show that the ambient temperature has only a minor influence in the ride-through time test results.

Depending on the used topology to reduce the input inrush current, the ambient temperature can have a major influence in the arising peak current after the sag test. Therefore, tests were performed at ambient temperatures of 25°C and +60°C.

It is assumed that semiconductor processing equipment is never used at lower temperatures than +25°C. Although the power supply itself is specified down to -25°C, a test at such low temperatures is not performed.

b) Mains frequency 50Hz vs. 60Hz:

Control measurements show that 50Hz testing is more critical than 60Hz testing. Therefore, unless otherwise noted, all tests were performed with a mains frequency of 50Hz.

c) Output voltage 24V vs. 28V:

The ride-through time depend on the stored energy in the input capacitors and the amount of output power. The output voltage is not essential as long as the output power is constant.

The adjusted output voltage has no influence in input currents peaks after input voltage sags. Therefore, unless otherwise noted, all tests were performed with an output voltage of 24Vdc.



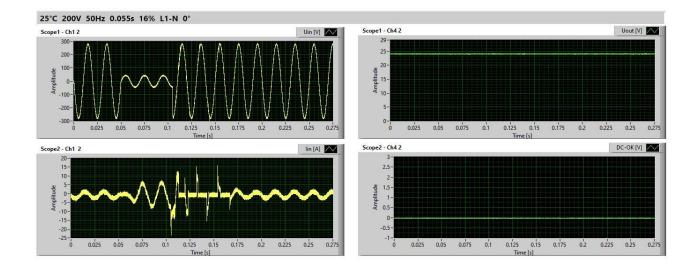
APPENDIX

Informational measurements at 200V

Input voltage	200Vac
Input Frequency	50Hz
Output voltage	24V
Output current	10A
Ambient temperature	25°C

Informational measurements

Sag duration	Voltage remaining	Positive peak current [A]	Negative peak current
[s]	[%]	Positive peak current [A]	[A]
0.020	0	14.1	-12.2
0.035	0	15.9	-21.6
0.055	16	15.9	-23.4
0.075	18	16.4	-23.4
0.085	20	21.6	-17.3
0.105	20	23	-17.3
0.175	22	14.1	-23
0.200	22	18.7	-19.2
0.255	22	13.1	-22
0.500	22	12.7	-14.5
1	22	11.2	-14.1
10	36	8.4	-8.9





Informational measurements at 230V

Input voltage	230Vac
Input Frequency	50Hz
Output voltage	24V
Output current	10A
Ambient temperature	25°C

Informational measurements

Sag duration [s]	Voltage remaining [%]	Positive peak current [A]	Negative peak current [A]
0.020	0	14.5	-12.7
0.035	0	25.3	-43.6
0.055	13	25.3	-53
0.075	17	23.4	-33.3
0.085	17	38.4	-24.8
0.105	19	24.8	-22
0.175	19	25.3	-24.8
0.200	19	17.3	-15
0.255	19	21.6	-28.1
0.500	19	15.9	-12.7
1	19	12.7	-15.5
10	31	8.9	-8.9

